


<b>Search Notes</b>  	<b>Application/Control No.</b>  10595200	<b>Applicant(s)/Patent Under Reexamination</b>  YANG ET AL.
	<b>Examiner</b>  Chang-Yu Wang	<b>Art Unit</b>  1649

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Sequence search: SEQ ID NOs: 1, 7, 2, 8, 9, 12, 13, 14. See sequence search results in SCORE (6/5/08)	6/10/08	CYW
EAST, STN: search strategy attached.	6/10/08	CYW
Inventor name search: EAST, STN, PALM.	6/10/08	CYW
PLUS search from STIC. See search results in eDAN (6/4/08).	6/10/08	CYW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner